

0.35-GHz TO 4-GHz QUADRATURE MODULATORS

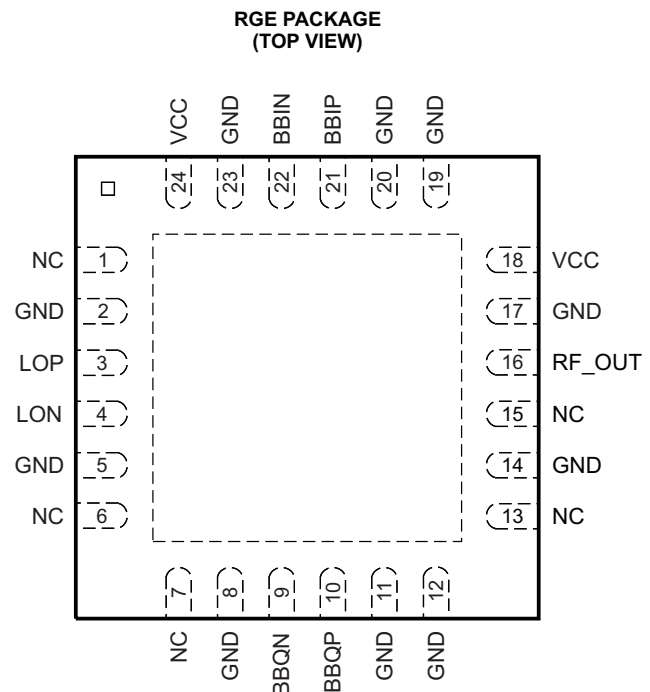
Check for Samples: [TRF370315](#), [TRF370333](#)

FEATURES

- 75-dBc Single-Carrier WCDMA ACPR at –11-dBm Channel Power
- Low Noise Floor: –163 dBm/Hz
- OIP3 of 23 dBm
- P1dB of 9 dBm
- Unadjusted Carrier Feedthrough of –40 dBm
- Unadjusted Side-Band Suppression of –40 dBc
- Single Supply: 4.5 V–5.5 V Operation
- Silicon Germanium Technology
- TRF370333 With 3.3-V CM at I, Q Baseband Inputs
- TRF370315 With 1.5-V CM at I, Q Baseband Inputs

APPLICATIONS

- Cellular Base Transceiver Station Transmit Channel
- CDMA: IS95, UMTS, CDMA2000, TD-SCDMA
- TDMA: GSM, IS-136, EDGE/UWC-136
- Wireless Local Loop
- Wireless MAN Wideband Transceivers



P0024-04

DESCRIPTION

The TRF370315 and TRF370333 are low-noise direct quadrature modulators, capable of converting complex modulated signals from baseband or IF directly up to RF. The TRF370315 and TRF370333 are ideal for high-performance direct RF modulation from 350 MHz up to 4 GHz. These modulators are implemented as a double-balanced mixer. The RF output block consists of a differential to single-ended converter and an RF amplifier capable of driving a single-ended 50-Ω load without any need of external components. The TRF370333 and TRF370315 devices have different common-mode voltage ratings at the I/Q baseband inputs. The TRF370315 requires a 1.5-V common-mode voltage, and the TRF370333 requires a 3.3-V common-mode voltage.



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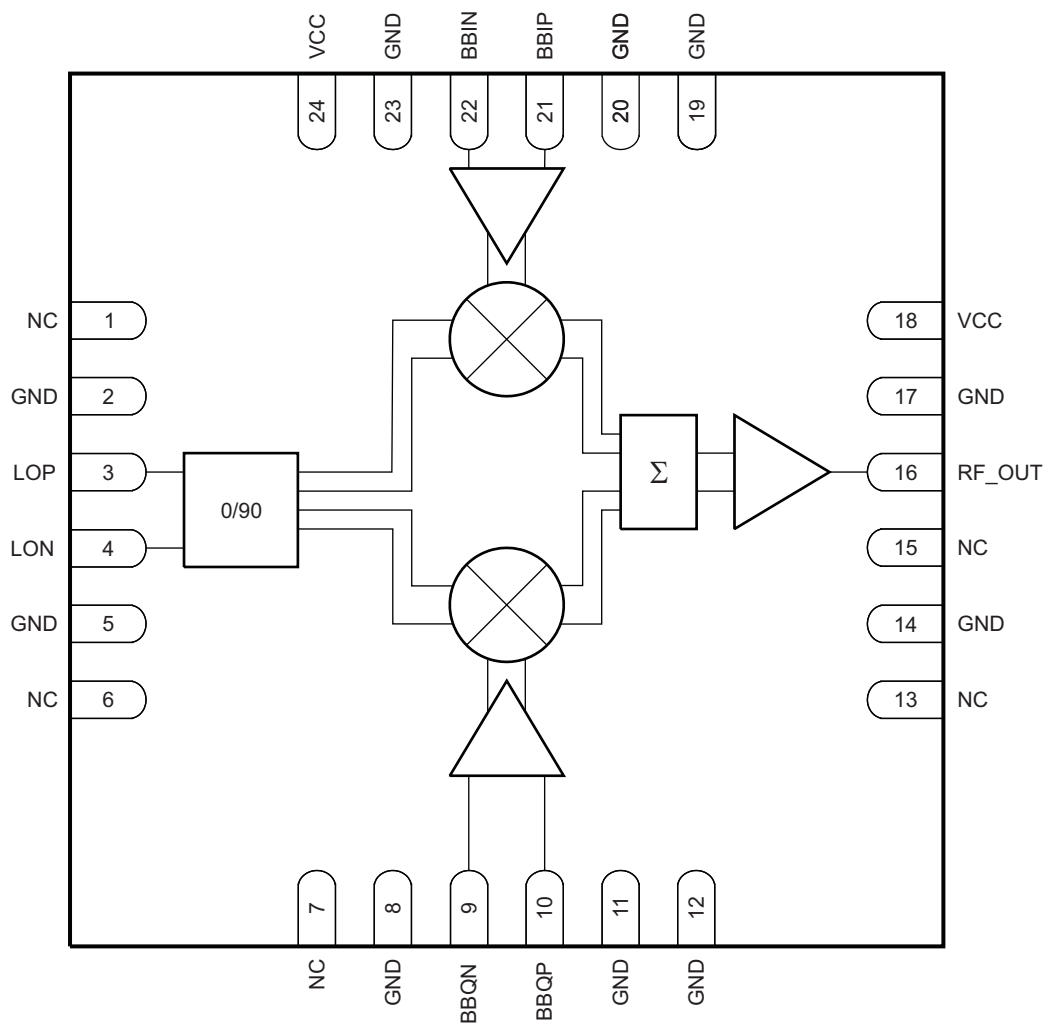
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This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

FUNCTIONAL BLOCK DIAGRAM



B0175-01

NOTE: NC = No connection

DEVICE INFORMATION

TERMINAL FUNCTIONS

TERMINAL		I/O	DESCRIPTION
NAME	NO.		
BBIN	22	I	In-phase input
BBIP	21	I	In-phase input
BBQN	9	I	In-quadrature input
BBQP	10	I	In-quadrature input
GND	2, 5, 8, 11, 12, 14, 17, 19, 20, 23	–	Ground
LON	4	I	Local oscillator input
LOP	3	I	Local oscillator input
NC	1, 6, 7, 13, 15	–	No connect
RF_OUT	16	O	RF output
VCC	18, 24	–	Power supply

ABSOLUTE MAXIMUM RATINGS⁽¹⁾

Over operating free-air temperature range (unless otherwise noted).

			VALUE ⁽²⁾	UNIT
Supply voltage range			–0.3 V to 6	V
Digital I/O voltage range			–0.3 V to $V_I + 0.3$	V
T_J	Operating virtual junction temperature range		–40 to 150	°C
T_A	Operating ambient temperature range		–40 to 85	°C
T_{stg}	Storage temperature range		–65 to 150	°C
ESD	Electrostatic discharge ratings	Human body model (HBM)	75	V
		Charged device model (CDM)	75	V

- (1) Stresses beyond those listed under *Absolute Maximum Ratings* may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under *Recommended Operating Conditions* is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.
- (2) All voltage values are with respect to network ground terminal.

RECOMMENDED OPERATING CONDITIONS

Over operating free-air temperature range (unless otherwise noted).

		MIN	NOM	MAX	UNIT
V_{CC}	Power-supply voltage	4.5	5	5.5	V

THERMAL CHARACTERISTICS

PARAMETER		TEST CONDITIONS	VALUE	UNIT
$R_{\theta JA}$	Thermal resistance, junction-to-ambient	High-K board, still air	29.4	°C/W
$R_{\theta JC}$	Thermal resistance, junction-to-case		18.6	°C/W

ELECTRICAL CHARACTERISTICS

Over operating free-air temperature range (unless otherwise noted).

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
DC Parameters						
I _{CC}	Total supply current (1.5 V CM)	T _A = 25°C	195		205	mA
	Total supply current (3.3 V CM)	T _A = 25°C	210		235	
LO Input (50-Ω, Single-Ended)						
f _{LO}	LO frequency range		0.35		4	GHz
	LO input power		–5	0	12	dBm
	LO port return loss		15			dB
Baseband Inputs						
V _{CM}	I and Q input dc common voltage	TRF370333	3.3			V
		TRF370315	1.5			
BW	1-dB input frequency bandwidth		350			MHz
Z _{i(single ended)}	Input impedance, resistance	TRF370333	10			kΩ
	Input impedance, parallel capacitance		3			pF
	Input impedance, resistance	TRF370315	5			kΩ
	Input impedance, parallel capacitance		3			pF

ELECTRICAL CHARACTERISTICS

Over recommended operating conditions, power supply = 5 V, $T_A = 25^\circ\text{C}$, $f_{LO} = 350\text{ MHz}$ at 0 dBm, TRF370333 (unless otherwise noted).

RF Output Parameters						
PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
G	Voltage gain ⁽¹⁾	TRF370315: Output RMS voltage over input I (or Q) RMS voltage		–4.18		dB
		TRF370333: Output RMS voltage over input I (or Q) RMS voltage		–4.0		dB
P1dB	Output compression point			9.4		dBm
IP3	Output IP3			24.5		dBm
IP2	Output IP2	Measured at $f_{LO} + 2 \times f_{BB}$		73.8		dBm
	Carrier feedthrough	Unadjusted		35.6		dBm
	Sideband suppression	Unadjusted		33.8		dBc
Output noise floor		DC only to BB inputs, 13 MHz offset from f_{LO}		–158.0		dBm/Hz
		1.8-MHz offset from f_{LO} ; 1 CW tone; $P_{out} = 0\text{ dBm}$		–152.6		
		6-MHz offset from f_{LO} ; 1 CW tone; $P_{out} = 0\text{ dBm}$		–157.4		

(1) Single 4-MHz CW baseband input tone, differential-ended 196 V_{RMS} .

ELECTRICAL CHARACTERISTICS

Over recommended operating conditions, power supply = 5 V, $T_A = 25^\circ\text{C}$, $f_{LO} = 400\text{ MHz}$ at 0 dBm, TRF370315 (unless otherwise noted).

RF Output Parameters						
PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
G	Voltage gain ⁽¹⁾	TRF370315: Output RMS voltage over input I (or Q) RMS voltage		–2.409		dB
		TRF370333: Output RMS voltage over input I (or Q) RMS voltage		–1.905		dB
P1dB	Output compression point			9.4		dBm
IP3	Output IP3		20	23		dBm
IP2	Output IP2	Measured at $f_{LO} + 2 \times f_{BB}$		62		dBm
	Carrier feedthrough	Unadjusted		–37		dBm
	Sideband suppression	Unadjusted		–39		dBc

(1) Single 4-MHz CW baseband input tone, differential-ended 196 V_{RMS} .

ELECTRICAL CHARACTERISTICS

Over recommended operating conditions, power supply = 5 V, $T_A = 25^\circ\text{C}$, $f_{LO} = 900\text{ MHz}$ at 0 dBm, TRF370315 (unless otherwise noted).

RF Output Parameters						
PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
G	Voltage gain ⁽¹⁾	TRF370315: Output RMS voltage over input I (or Q) RMS voltage		−3.552		dB
		TRF370333: Output RMS voltage over input I (or Q) RMS voltage		−2.79		dB
P1dB	Output compression point			9		dBm
IP3	Output IP3		20	23		dBm
IP2	Output IP2	Measured at f _{LO} + 2 × f _{BB}		63		dBm
	Carrier feedthrough	Unadjusted		−37		dBm
	Sideband suppression	Unadjusted		−42		dBc
	Output return loss			9		dB
	Output noise floor	DC only to BB inputs, 13 MHz offset from f _{LO}		−160.4		dBm/Hz
		1.8-MHz offset from f _{LO} ; 1 CW tone; P _{out} = 0 dBm		−156.6		
		6-MHz offset from f _{LO} ; 1 CW tone; P _{out} = 0 dBm		−158.5		
EVM	Error vector magnitude (rms)	1 EDGE signal, P _{out} = −5 dBm		0.59%		
		1 EDGE signal, P _{out} = 0 dBm		0.63%		
		1 EDGE signal, P _{out} = 0 dBm, 2nd harmonic of LO = −15 dBm, 3rd harmonic of LO = −33 dBm ⁽²⁾		1%		

(1) Single 4-MHz CW baseband input tone, differential-ended 196 V_{RMS}.

(2) The second- and third-harmonic tests were made independently at each frequency.

ELECTRICAL CHARACTERISTICS

Over recommended operating conditions, power supply = 5 V, $T_A = 25^\circ\text{C}$, $f_{LO} = 1800\text{ MHz}$ at 0 dBm, TRF370315 (unless otherwise noted).

RF Output Parameters							
PARAMETER		TEST CONDITIONS		MIN	TYP	MAX	UNIT
G	Voltage gain ⁽¹⁾	TRF370315: Output RMS voltage over input I (or Q) RMS voltage			−3.345		dB
		TRF370333: Output RMS voltage over input I (or Q) RMS voltage			−2.367		dB
P1dB	Output compression point				9.5		dBm
IP3	Output IP3			20	23		dBm
IP2	Output IP2	Measured at f _{LO} + 2 × f _{BB}			55		dBm
	Carrier feedthrough	Unadjusted			−40		dBm
	Sideband suppression	Unadjusted			−47		dBc
	Output return loss				8		dB
	Output noise floor	DC only to BB inputs, 13 MHz offset from f _{LO}			−162.6		dBm/Hz
		1.8-MHz offset from f _{LO} ; 1 CW tone; P _{out} = 0 dBm			−160		
		6-MHz offset from f _{LO} ; 1 CW tone; P _{out} = 0 dBm			−159.4		
EVM	Error vector magnitude (rms)	1 EDGE signal, P _{out} = −5 dBm			0.66%		
		1 EDGE signal, P _{out} = 0 dBm			0.74%		
		1 EDGE signal, P _{out} = 0 dBm, 2nd harmonic of LO = −15.5 dBm, 3rd harmonic of LO = −30 dBm ⁽²⁾			1%		

(1) Single 4-MHz CW baseband input tone, differential-ended 196 V_{RMS}.

(2) The second- and third-harmonic tests were made independently at each frequency.

ELECTRICAL CHARACTERISTICS

Over recommended operating conditions, power supply = 5 V, $T_A = 25^\circ\text{C}$, $f_{LO} = 1960 \text{ MHz}$ at 0 dBm, TRF370315 (unless otherwise noted).

RF Output Parameters							
PARAMETER		TEST CONDITIONS		MIN	TYP	MAX	UNIT
G	Voltage gain ⁽¹⁾	TRF370315: Output RMS voltage over input I (or Q) RMS voltage			–3.449		dB
		TRF370333: Output RMS voltage over input I (or Q) RMS voltage			–2.479		dB
P1dB	Output compression point				9.5		dBm
IP3	Output IP3, TRF370315			20	23		dBm
	Output IP3, TRF370333			18	20		
IP2	Output IP2	Measured at f _{LO} + 2 × f _{BB}			55		dBm
	Carrier feedthrough	Unadjusted			–40		dBm
	Sideband suppression	Unadjusted			–47		dBc
	Output return loss				8		dB
	Output noise floor	DC only to BB inputs, 13 MHz offset from f _{LO}			–162.6		dBm/Hz
		1.8-MHz offset from f _{LO} ; 1 CW tone; P _{out} = 0 dBm			–160		
		6-MHz offset from f _{LO} ; 1 CW tone; P _{out} = 0 dBm			–159.4		
EVM	Error vector magnitude (rms)	1 EDGE signal, P _{out} = –5 dBm			0.66%		
		1 EDGE signal, P _{out} = 0 dBm			0.74%		
		1 EDGE signal, P _{out} = 0 dBm, 2nd harmonic of LO = –15.5 dBm, 3rd harmonic of LO = –30 dBm ⁽²⁾			1%		

(1) Single 4-MHz CW baseband input tone, differential-ended 196 V_{RMS}.

(2) The second- and third-harmonic tests were made independently at each frequency.

ELECTRICAL CHARACTERISTICS

Over recommended operating conditions, power supply = 5 V, $T_A = 25^\circ\text{C}$, $f_{LO} = 2140 \text{ MHz}$ at 0 dBm, TRF370315 (unless otherwise noted).

RF Output Parameters						
PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
G	Voltage gain ⁽¹⁾	TRF370315: Output RMS voltage over input I (or Q) RMS voltage		−3.432		dB
		TRF370333: Output RMS voltage over input I (or Q) RMS voltage		−2.791		dB
P1dB	Output compression point			9.5		dBm
IP3	Output IP3, TRF370315		20	23		dBm
	Output IP3, TRF370333		18	21		
IP2	Output IP2	Measured at $f_{LO} + 2 \times f_{BB}$		58		dBm
	Carrier feedthrough	Unadjusted		−40		dBm
	Sideband suppression	Unadjusted		−47		dBc
	Output return loss			8.5		dB
	Output noise floor	20-MHz offset from f_{LO} ; dc only to BB inputs		−163		dBm/Hz
		20-MHz offset from f_{LO} ; 1 WCDMA signal; $P_{in} = -20.5$ dBVrms (I and Q input)		−162		
ACPR	Adjacent-channel power ratio	1 WCDMA signal; $P_{out} = -13$ dBm		−75.8		dBc
		1 WCDMA signal; $P_{out} = -9$ dBm		−72		
		4 WCDMA signals; $P_{out} = -23$ dBm per carrier		−68		
	Alternate-channel power ratio	1 WCDMA signal; $P_{out} = -13$ dBm		−79		dBc
		1 WCDMA signal; $P_{out} = -9$ dBm		−80.5		
		4 WCDMA signals; $P_{out} = -23$ dBm per carrier		−69		

(1) Single 4-MHz CW baseband input tone, differential-ended 196 V_{RMS}.

ELECTRICAL CHARACTERISTICS

Over recommended operating conditions, power supply = 5 V, $T_A = 25^\circ\text{C}$, $f_{LO} = 2500\text{ MHz}$ at 0 dBm, TRF370315 (unless otherwise noted).

RF Output Parameters					
PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
G Voltage gain ⁽¹⁾	TRF370315: Output RMS voltage over input I (or Q) RMS voltage		–2.892		dB
	TRF370333: Output RMS voltage over input I (or Q) RMS voltage		–1.379		dB
P1dB Output compression point			9.5		dBm
IP3 Output IP3		18	21		dBm
IP2 Output IP2	Measured at $f_{LO} + 2 \times f_{BB}$		63		dBm
Carrier feedthrough	Unadjusted		–38		dBm
Sideband suppression	Unadjusted		–47		dBc

(1) Single 4-MHz CW baseband input tone, differential-ended 196 V_{RMS}.

ELECTRICAL CHARACTERISTICS

Over recommended operating conditions, power supply = 5 V, $T_A = 25^\circ\text{C}$, $f_{LO} = 3600\text{ MHz}$ at 0 dBm, TRF370315 (unless otherwise noted).

RF Output Parameters					
PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
G Voltage gain ⁽¹⁾	TRF370315: Output RMS voltage over input I (or Q) RMS voltage		–1.265		dB
	TRF370333: Output RMS voltage over input I (or Q) RMS voltage		1.529		dB
P1dB Output compression point			9.5		dBm
IP3 Output IP3		20	23		dBm
IP2 Output IP2	Measured at $f_{LO} + 2 \times f_{BB}$		63		dBm
Carrier feedthrough	Unadjusted		–41		dBm
Sideband suppression	Unadjusted		–45		dBc

(1) Single 4-MHz CW baseband input tone, differential-ended 196 V_{RMS}.

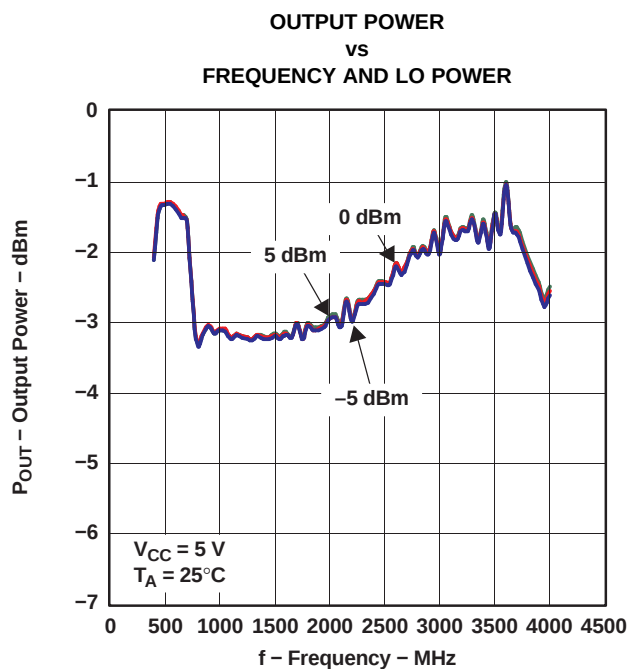
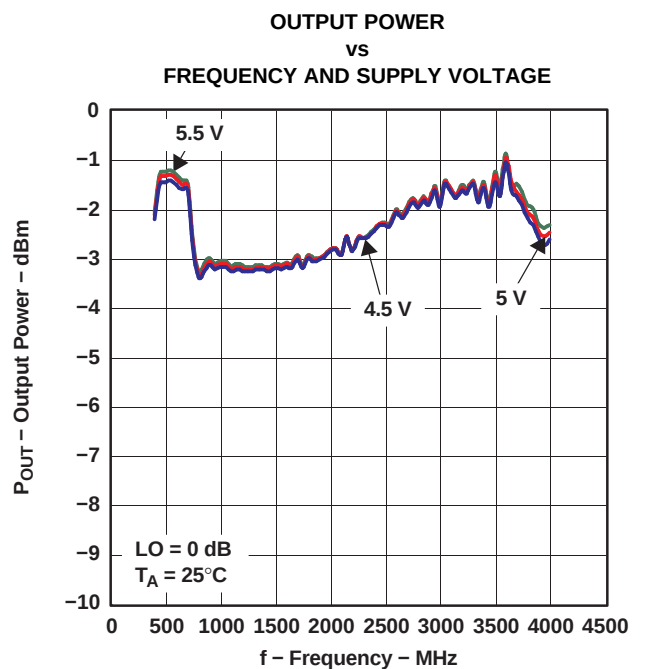
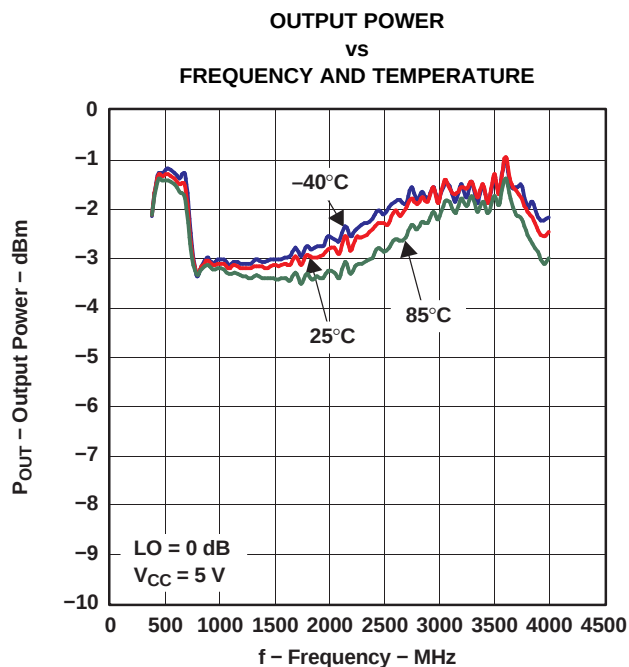
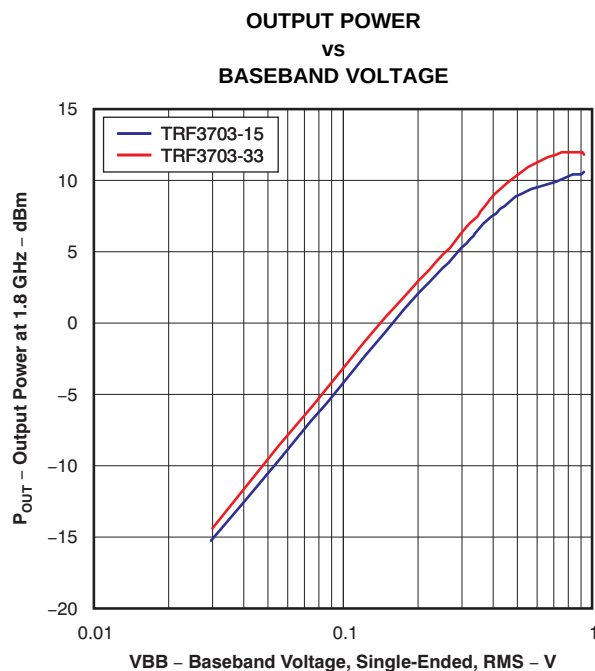
ELECTRICAL CHARACTERISTICS

Over recommended operating conditions, power supply = 5 V, $T_A = 25^\circ\text{C}$, $f_{LO} = 4000\text{ MHz}$ at 0 dBm, TRF370315 (unless otherwise noted).

RF Output Parameters					
PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
G Voltage gain ⁽¹⁾	TRF370315: Output RMS voltage over input I (or Q) RMS voltage		–2.242		dB
	TRF370333: Output RMS voltage over input I (or Q) RMS voltage		0.543		dB
P1dB Output compression point			9		dBm
IP3 Output IP3		19	22		dBm
IP2 Output IP2	Measured at $f_{LO} + 2 \times f_{BB}$		50		dBm
Carrier feedthrough	Unadjusted		–37		dBm
Sideband suppression	Unadjusted		–40		dBc

(1) Single 4-MHz CW baseband input tone, differential-ended 196 V_{RMS}.

TYPICAL CHARACTERISTICS



TYPICAL CHARACTERISTICS (continued)

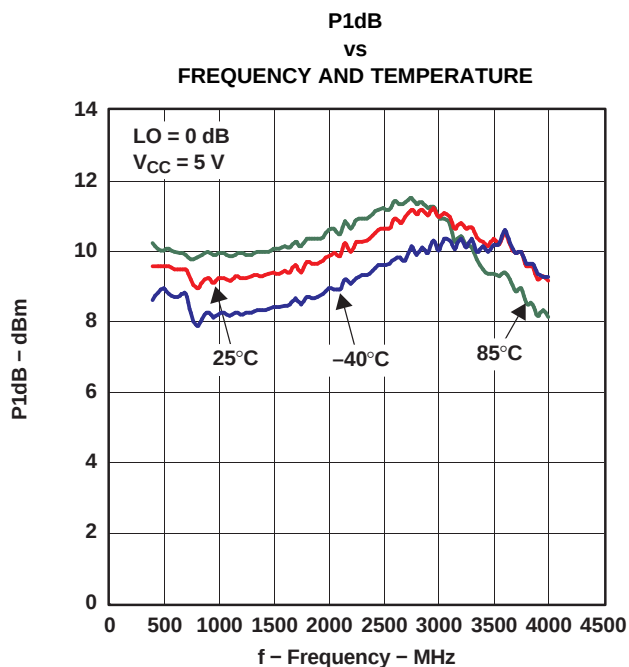


Figure 5.

G001

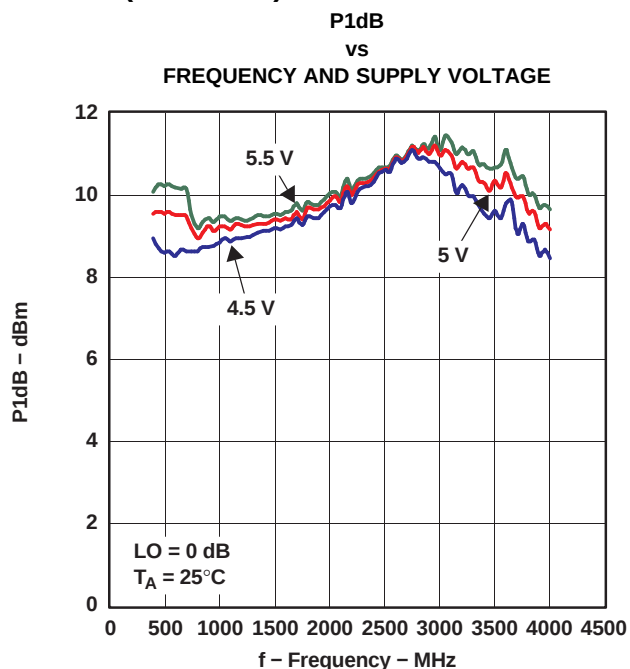


Figure 6.

G002

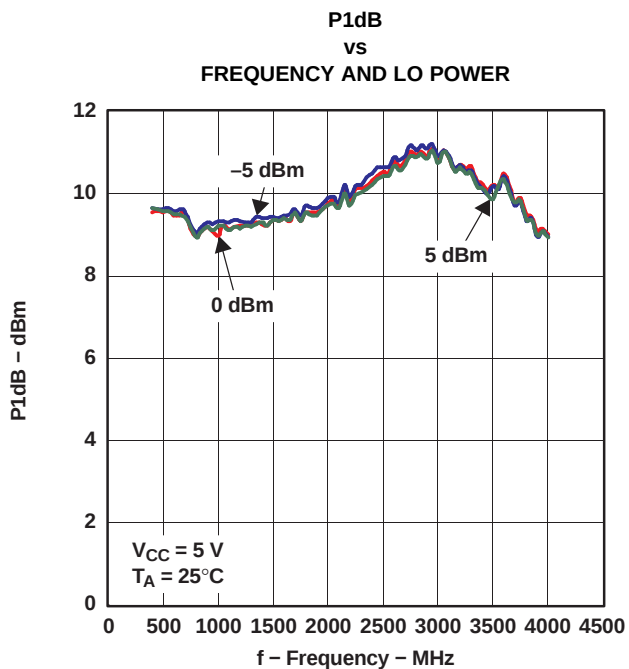


Figure 7.

G003

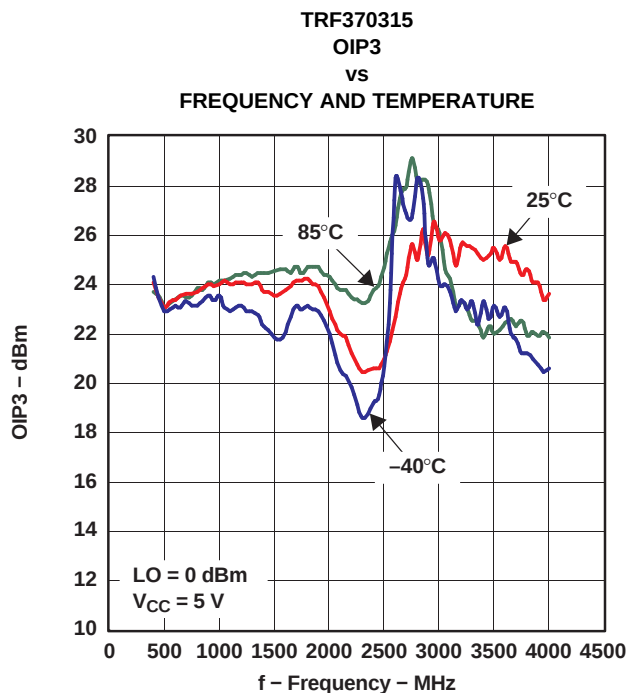
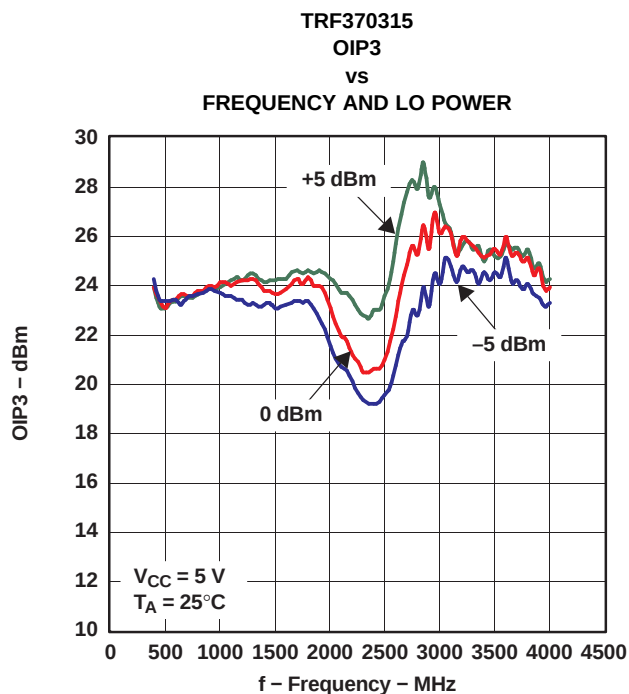
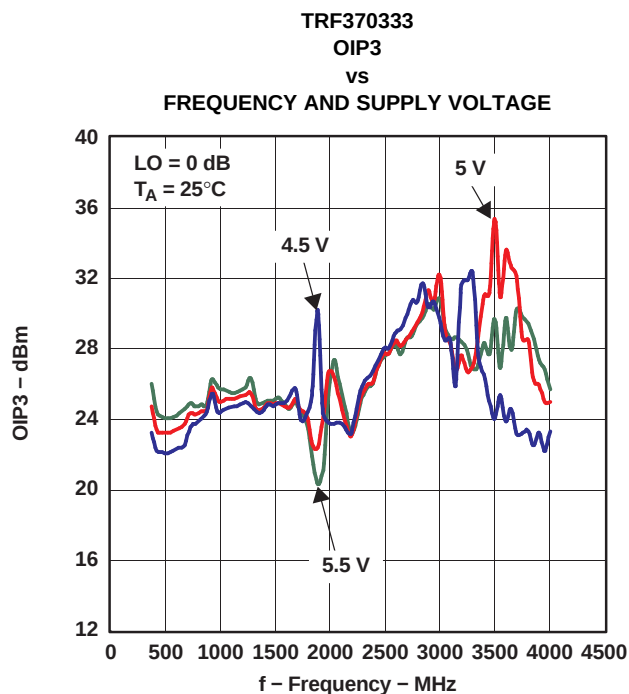
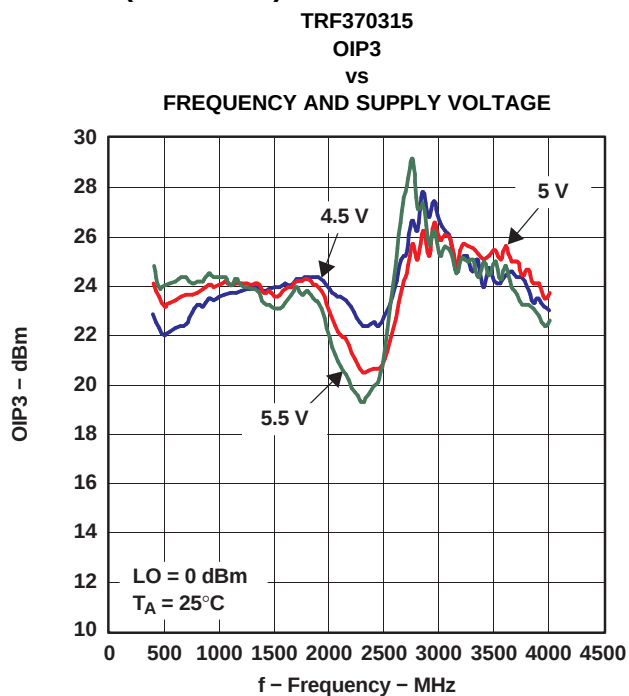
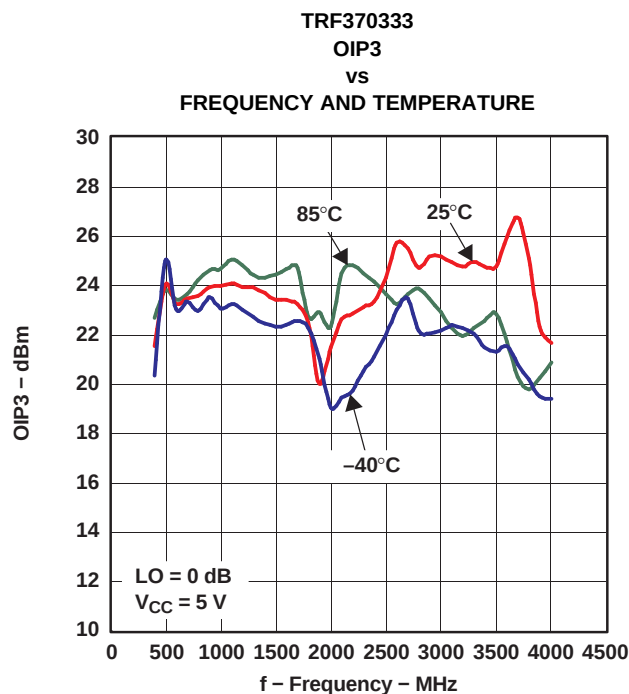


Figure 8.

G014

TYPICAL CHARACTERISTICS (continued)



TYPICAL CHARACTERISTICS (continued)

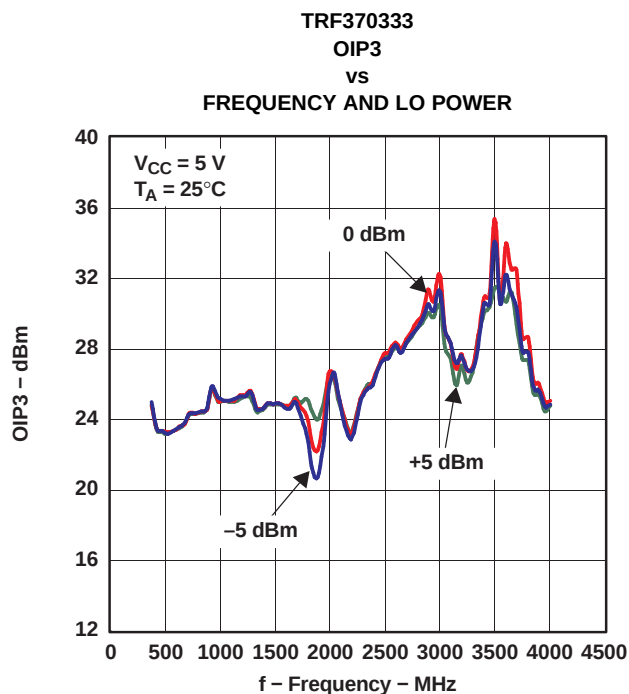


Figure 13.

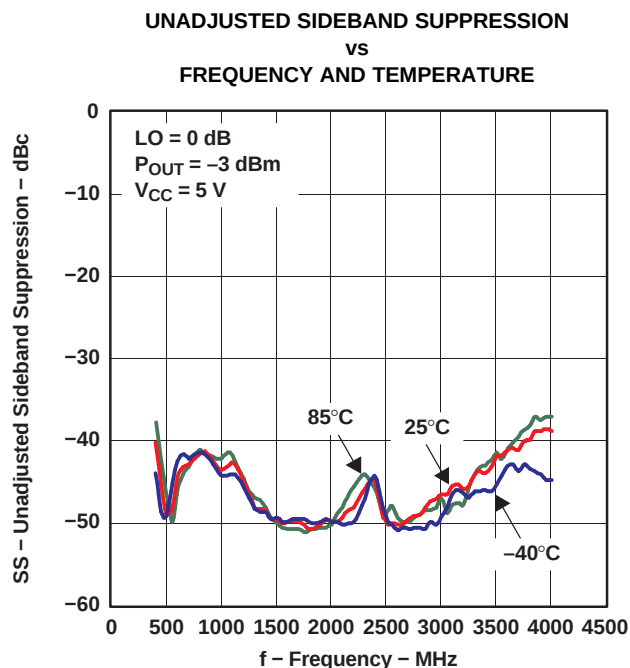


Figure 14.

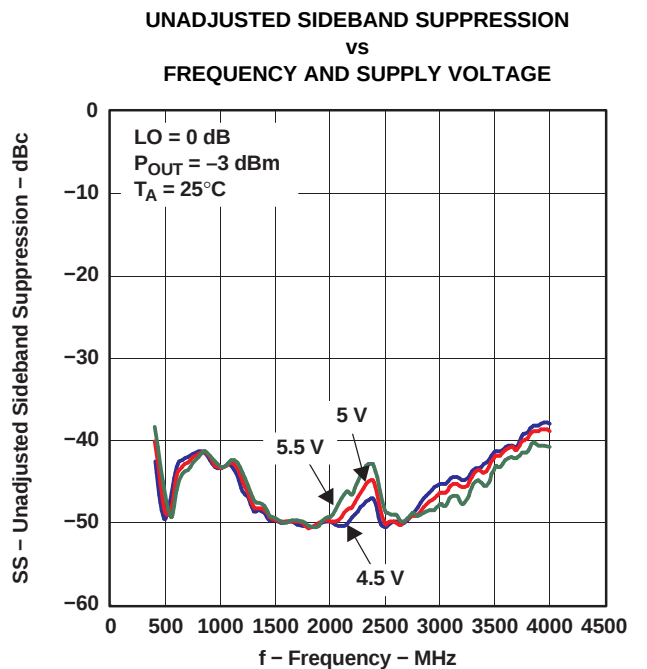


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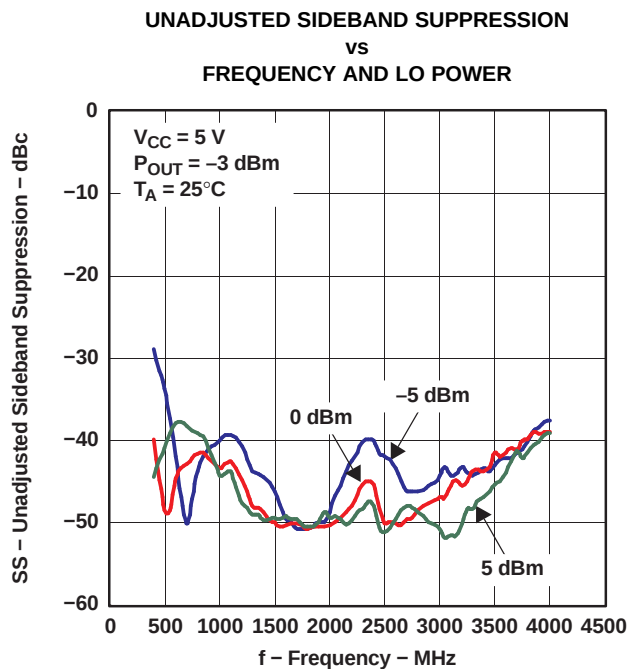


Figure 16.

TYPICAL CHARACTERISTICS (continued)

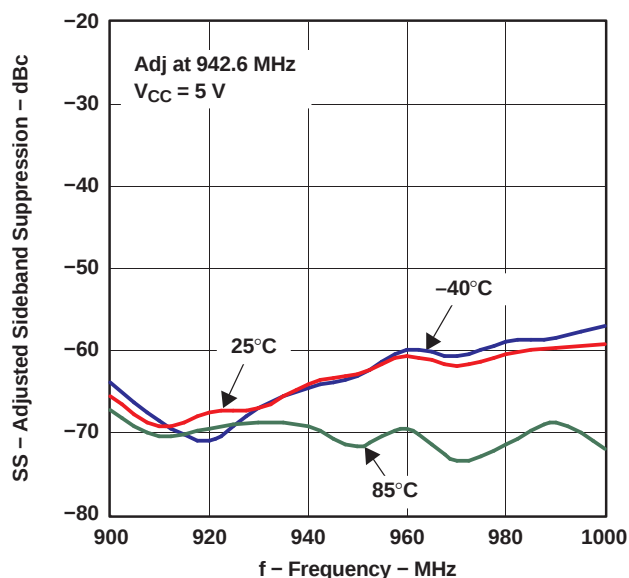
ADJUSTED SIDEBAND SUPPRESSION
vs
FREQUENCY AND TEMPERATURE

Figure 17.

G016

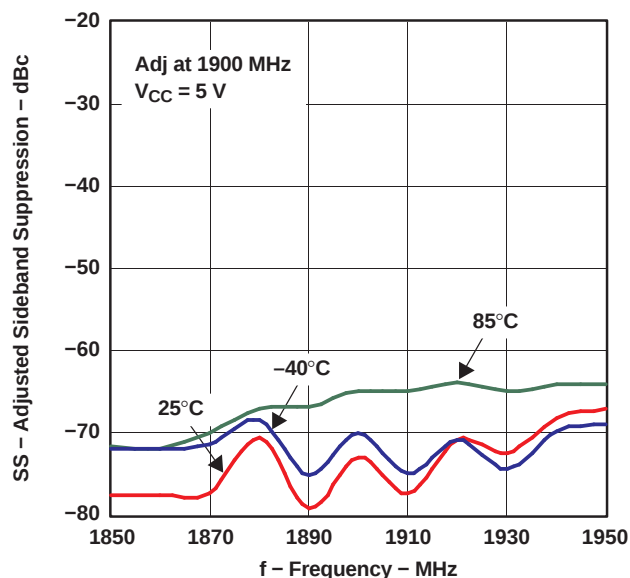
ADJUSTED SIDEBAND SUPPRESSION
vs
FREQUENCY AND TEMPERATURE

Figure 18.

G017

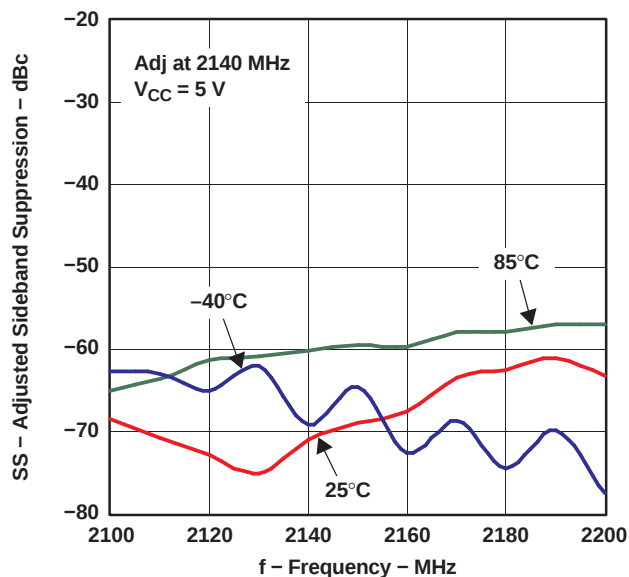
ADJUSTED SIDEBAND SUPPRESSION
vs
FREQUENCY AND TEMPERATURE

Figure 19.

G018

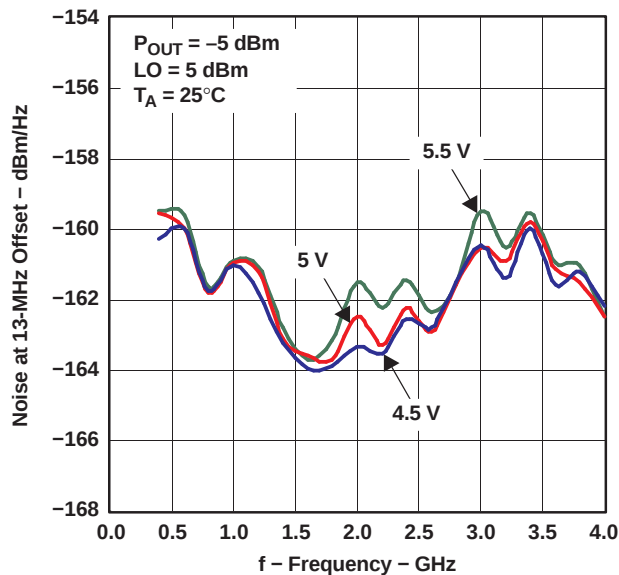
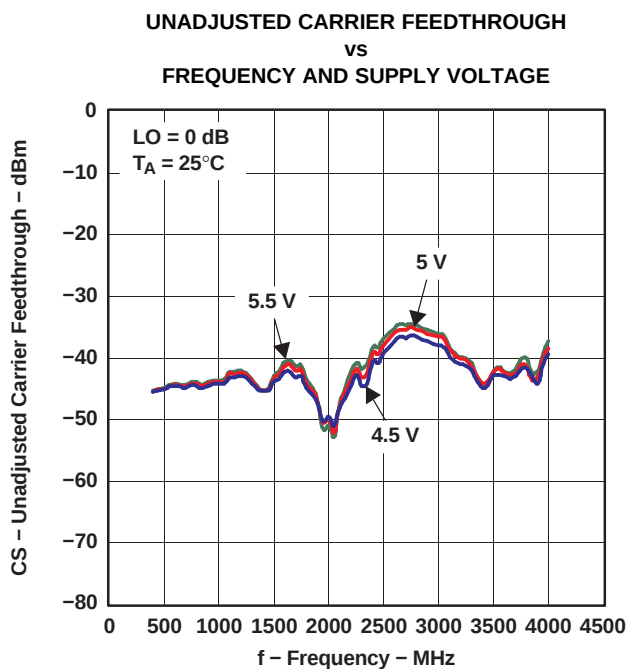
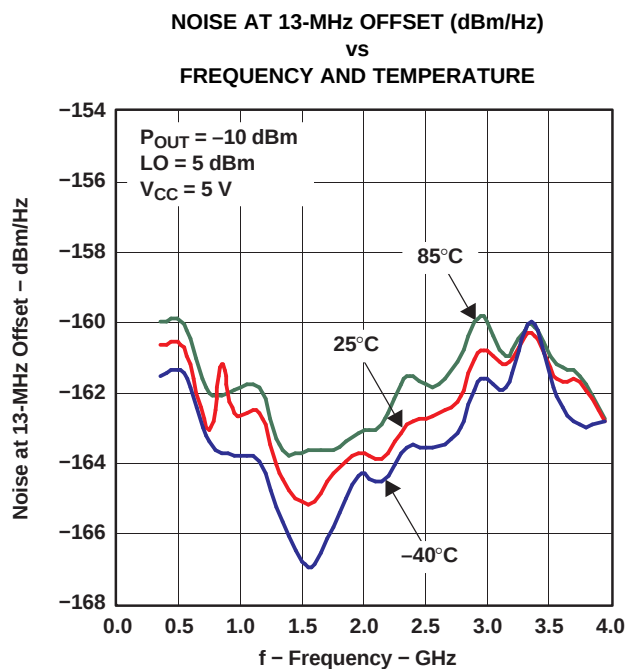
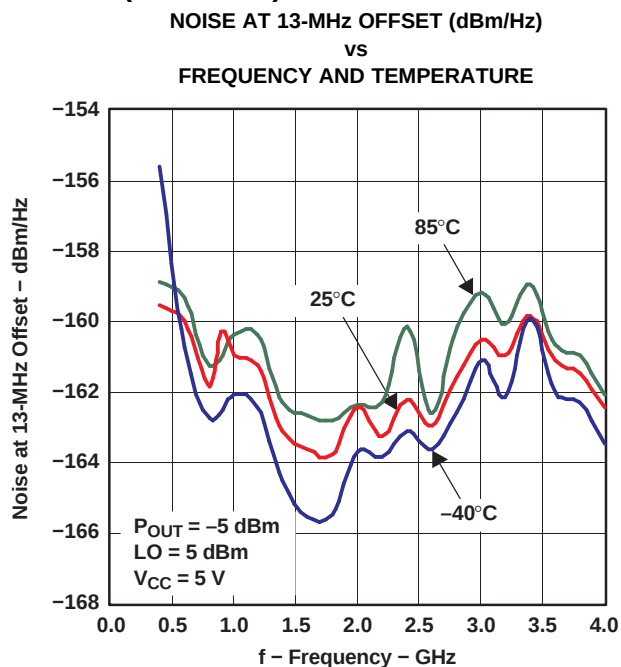
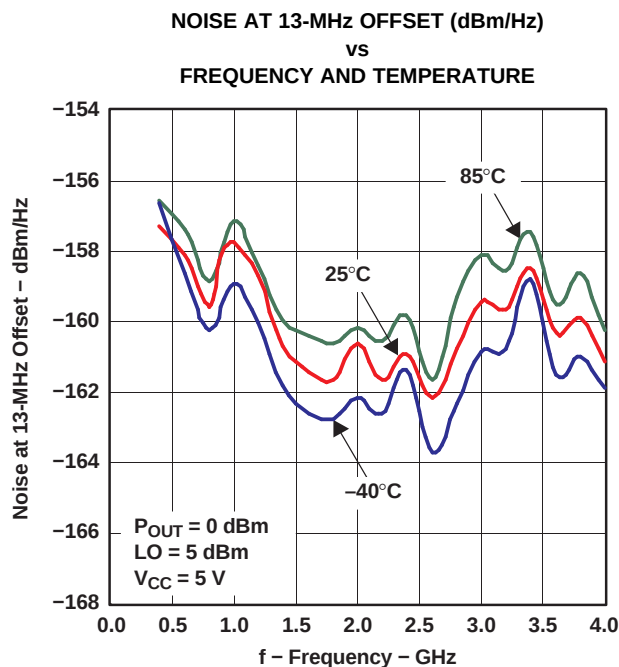
NOISE AT 13-MHz OFFSET (dBm/Hz)
vs
FREQUENCY AND SUPPLY VOLTAGE

Figure 20.

G019

TYPICAL CHARACTERISTICS (continued)

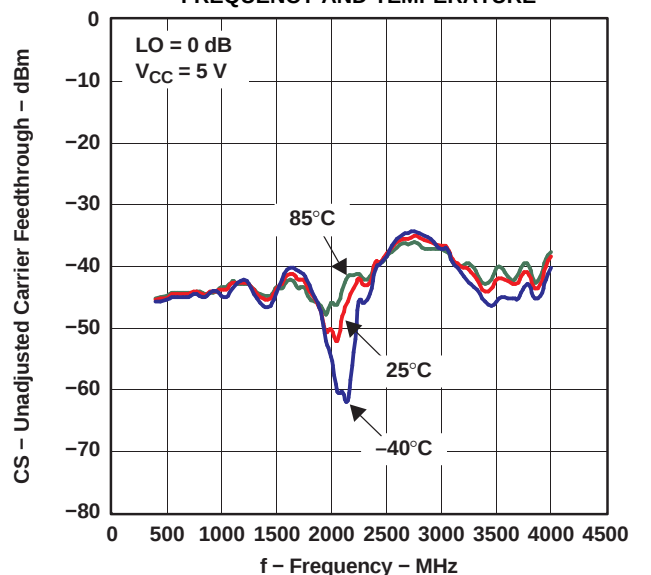


TYPICAL CHARACTERISTICS (continued)

UNADJUSTED CARRIER FEEDTHROUGH

vs

FREQUENCY AND TEMPERATURE



G026

Figure 25.

APPLICATION INFORMATION AND EVALUATION BOARD

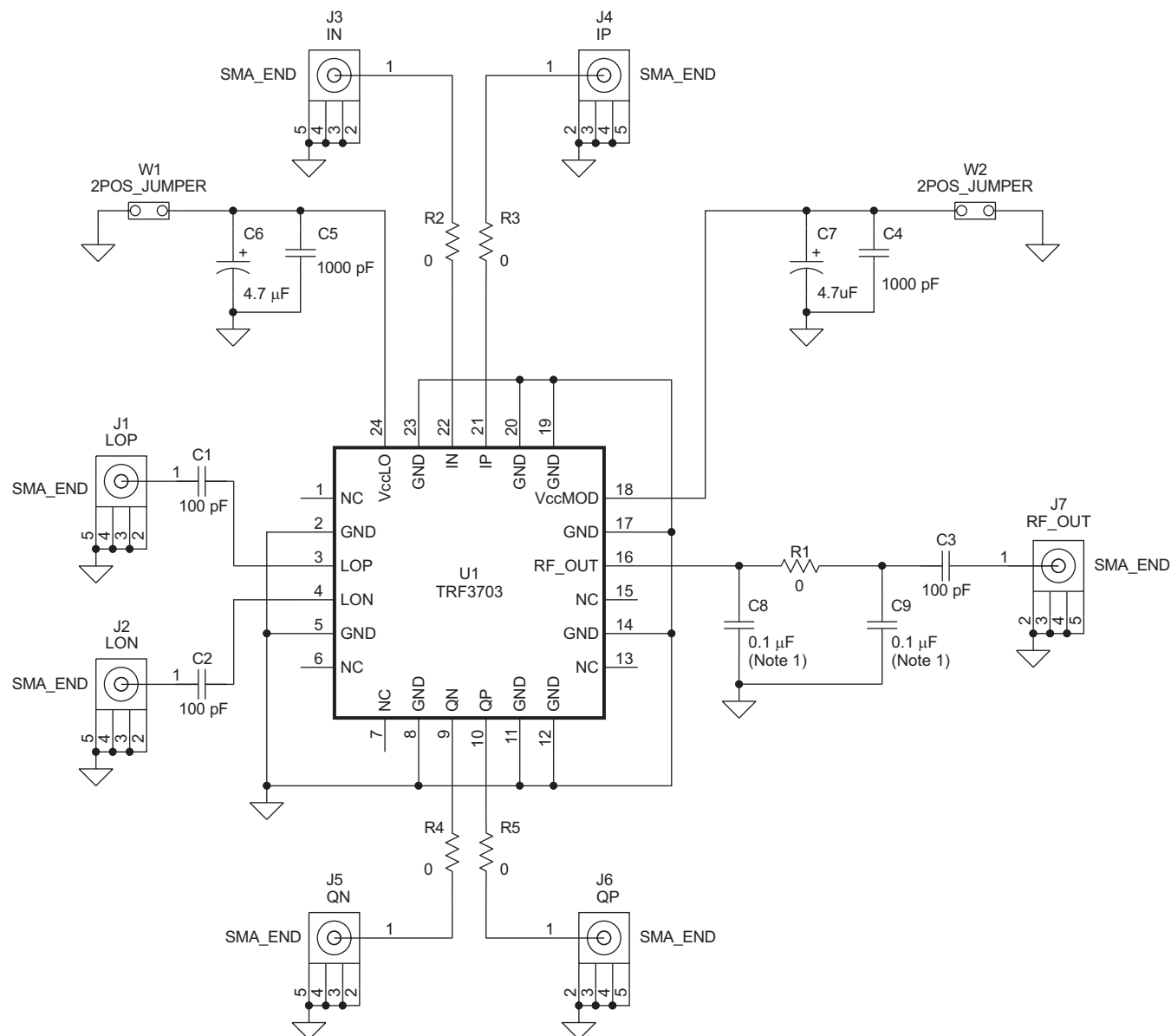
Basic Connections

- See [Figure 26](#) for proper connection of the TRF3703315 and TRF370333 modulator.
- Connect a single power supply (4.5 V–5.5 V) to pins 18 and 24. These pins should be decoupled as shown on pins 4, 5, 6, and 7.
- Connect pins 2, 5, 8, 11, 12, 14, 17, 19, 20, and 23 to GND.
- Connect a single-ended LO source of desired frequency to LOP (amplitude between –5 dBm and 12 dBm). This should be ac-coupled through a 100-pF capacitor.
- Terminate the ac-coupled LON with 50 Ω to GND.
- Connect a baseband signal to pins 21 = I, 22 = $\bar{I}$, 10 = Q, and 9 = $\bar{Q}$.
- The differential baseband inputs should be set to the proper level, 3.3 V for the TRF370333 or 1.5 V for the TRF370315.
- RF_OUT, pin 16, can be fed to a spectrum analyzer set to the desired frequency, LO $\pm$ baseband signal. This pin should also be ac-coupled through a 100-pF capacitor.
- All NC pins can be left floating.

ESD Sensitivity

RF devices may be extremely sensitive to electrostatic discharge (ESD). To prevent damage from ESD, devices should be stored and handled in a way that prevents the build-up of electrostatic voltages that exceed the rated level. Rated ESD levels should also not be exceeded while the device is installed on a printed circuit board (PCB). Follow these guidelines for optimal ESD protection:

- Low ESD performance is not uncommon in RF ICs; see the [Absolute Maximum Ratings](#) table. Therefore, customers' ESD precautions should be consistent with these ratings.
- The device should be robust once assembled onto the PCB **unless** external inputs (connectors, etc.) directly connect the device pins to off-board circuits.

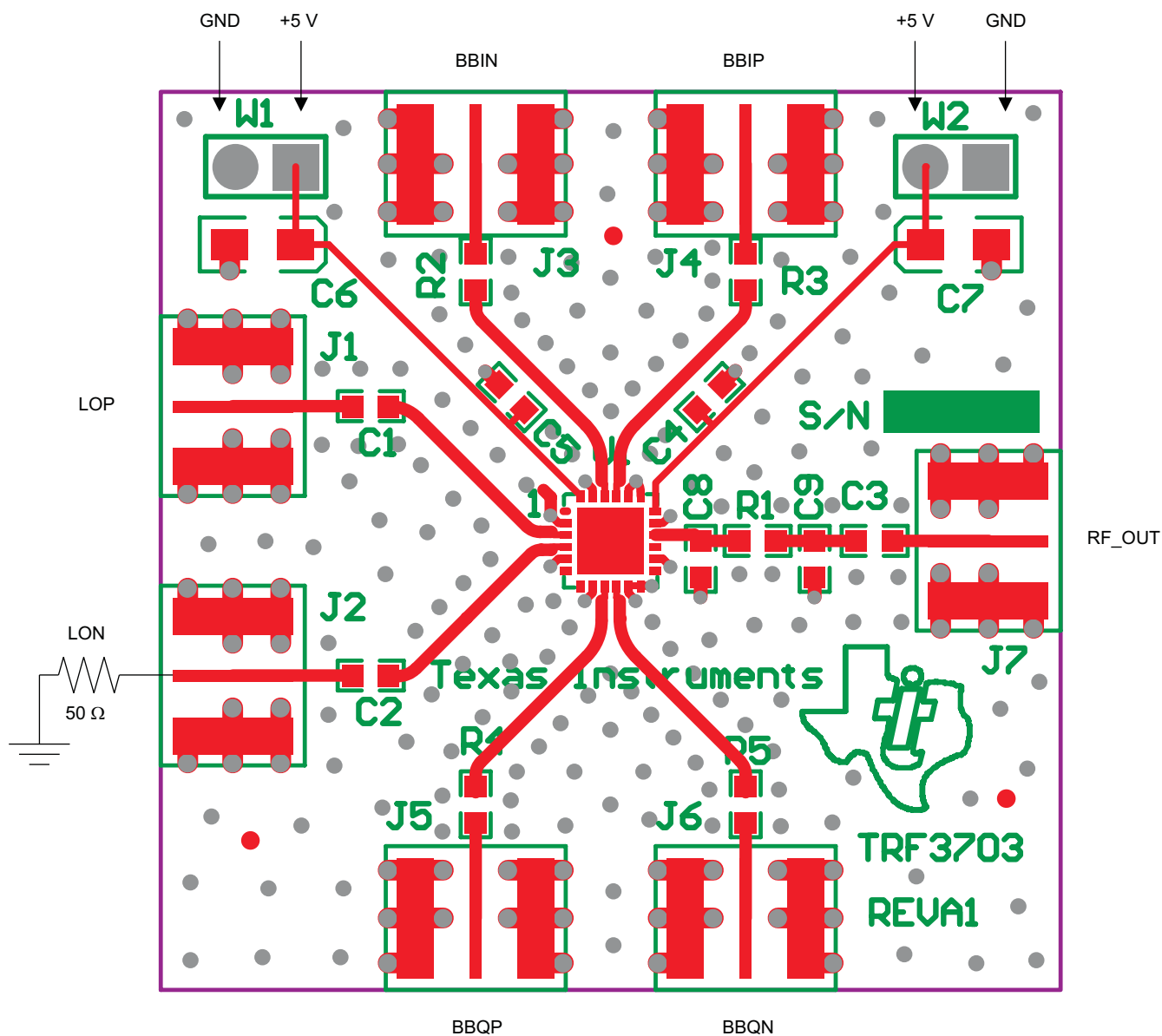


S0214-01

(1) Do not install.

Figure 26. TRF3703 EVM Schematic

Figure 27 shows the top view of the TRF3703 EVM board.



K001

Figure 27. TRF3703 EVM Board Layout

Table 1. Bill of Materials for TRF3703 EVM

Value	Footprint	QTY	Part Number	Vendor	Digi-Key Number	REF DES	Not Installed
Tantalum 4.7-μF, 10-V, 10% capacitor	3216	2	T491A475K010AS	KEMET	399-1561-1-ND	C6, C7	
1000-pF, 50-V, 5% capacitor	603	2	ECJ-1VC1H102J	Panasonic	PCC2151CT-ND	C4, C5	
100-pF, 50-V, 5% capacitor	603	3	ECJ-1VC1H101J	Panasonic	PCC101ACVCT-ND	C1, C2, C3	
Capacitor	603	0					C8, C9
0-Ω resistor, 1/10-W, 5%	603	5	ERJ-3GEY0R00V	Panasonic	P0.0GCT-ND	R1, R2, R3, R4, R5	

Table 1. Bill of Materials for TRF3703 EVM (continued)

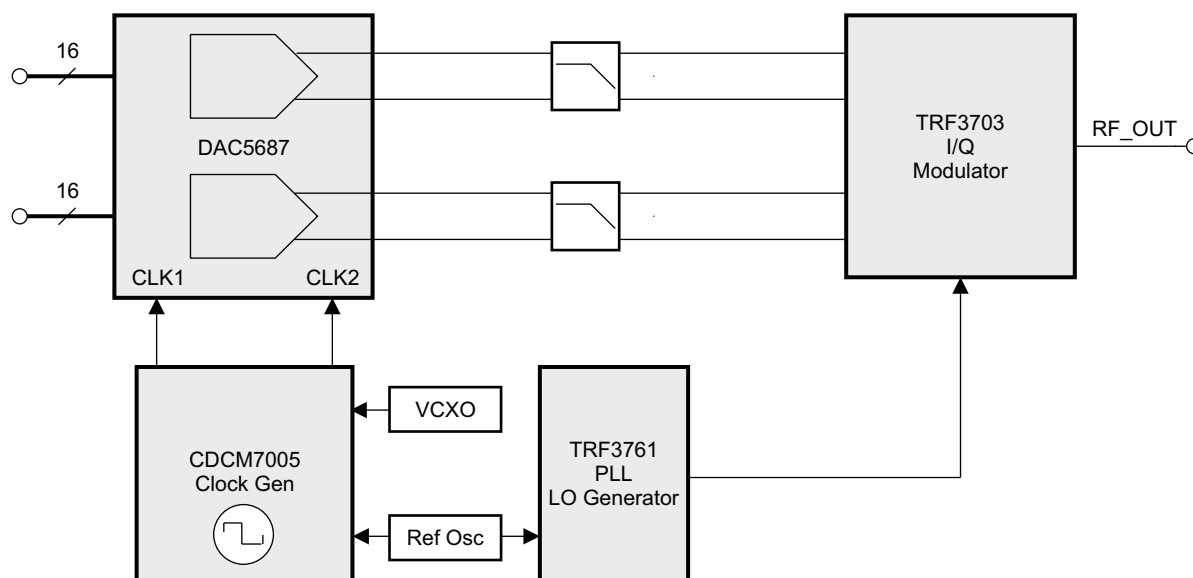
Value	Footprint	QTY	Part Number	Vendor	Digi-Key Number	REF DES	Not Installed
TRF3703	24-QFN-PP-4X4MM	1		TI		U1	
SMA connectors	SMA_END_SMALL	6	16F3627	Newark	142-0711-821	J1, J2, J3, J4, J5, J6, J7	
2POS_HEADER	2POS_JUMP	2	HTSW-150-07-L-S	SAMTEC	N/A	W1, W2	

GSM Applications

The TRF370315 and TRF370333 are suited for GSM applications because of the high linearity and low noise level over the entire recommended operating range. These devices also have excellent EVM performance, which makes them ideal for the stringent GSM/EDGE applications.

WCDMA Applications

The TRF370315 and TRF370333 are also optimized for WCDMA applications where both adjacent-channel power ratio (ACPR) and noise density are critically important. Using Texas instruments' DAC568X series of high-performance digital-to-analog converters as depicted in [Figure 28](#), excellent ACPR levels were measured with one-, two-, and four-WCDMA carriers. See *Electrical Characteristics*, $f_{LO} = 2140$ MHz for exact ACPR values.



B0176-01

Figure 28. Typical Transmit Setup Block Diagram

DEFINITION OF SPECIFICATIONS

Unadjusted Carrier Feedthrough

This specification measures the amount by which the local oscillator component is attenuated in the output spectrum of the modulator relative to the carrier. This further assumes that the baseband inputs delivered to the pins of the TRF370315 and TRF370333 are perfectly matched to have the same dc offset (VCM). This includes all four baseband inputs: I, $\bar{I}$, Q, and $\bar{Q}$. This is measured in dBm.

Adjusted (Optimized) Carrier Feedthrough

This differs from the unadjusted suppression number in that the baseband input dc offsets are iteratively adjusted around their theoretical value of VCM to yield the maximum suppression of the LO component in the output spectrum. This is measured in dBm.

Unadjusted Sideband Suppression

This specification measures the amount by which the unwanted sideband of the input signal is attenuated in the output of the modulator, relative to the wanted sideband. This further assumes that the baseband inputs delivered to the modulator input pins are perfectly matched in amplitude and are exactly 90° out of phase. This is measured in dBc.

Adjusted (Optimized) Sideband Suppression

This differs from the unadjusted sideband suppression in that the baseband inputs are iteratively adjusted around their theoretical values to maximize the amount of sideband suppression. This is measured in dBc.

Suppressions Overtemperature

This specification assumes that the user has gone through the optimization process for the suppression in question, and set the optimal settings for the I, Q inputs. This specification then measures the suppression when temperature conditions change after the initial calibration is done.

Figure 29 shows a simulated output and illustrates the respective definitions of various terms used in this data sheet. The graph assumes a baseband input of 50 kHz.

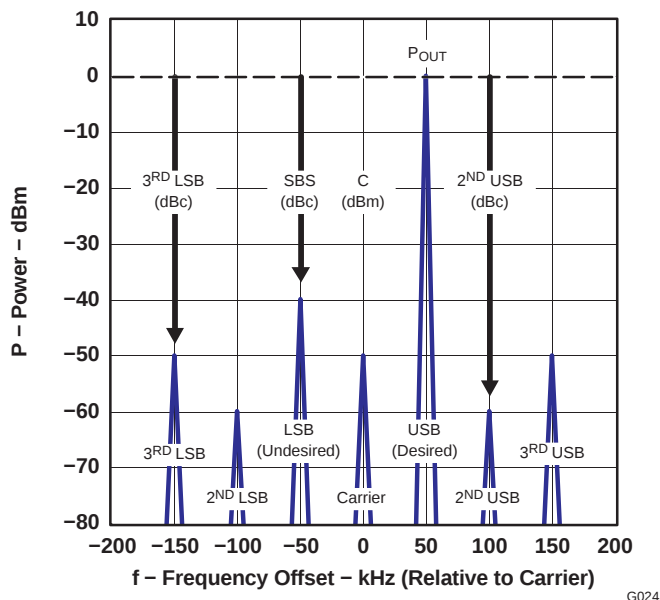


Figure 29. Graphical Illustration of Common Terms

REVISION HISTORY

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

Changes from Revision I (July, 2010) to Revision J	Page
• Changed <i>voltage gain</i> specifications for $f_{LO} = 350$ -MHz performance data	4
• Updated <i>voltage gain</i> specifications for $f_{LO} = 400$ -MHz performance data	4
• Revised <i>voltage gain</i> specifications for $f_{LO} = 900$ -MHz performance data	5
• Changed <i>voltage gain</i> specifications for $f_{LO} = 1800$ -MHz performance data	5
• Revised <i>voltage gain</i> specifications for $f_{LO} = 1960$ -MHz performance data	6
• Updated <i>voltage gain</i> specifications for $f_{LO} = 2140$ -MHz performance data	6
• Revised <i>voltage gain</i> specifications for $f_{LO} = 2500$ -MHz performance data	7
• Changed <i>voltage gain</i> specifications for $f_{LO} = 3600$ -MHz performance data	7
• Updated <i>voltage gain</i> specifications for $f_{LO} = 4000$ -MHz performance data	7
• Replaced Figure 1	8

Changes from Revision H (January, 2010) to Revision I	Page
• Changed document title to reflect 0.35-GHz minimum operating level	1
• Updated <i>Description</i> section to reflect 350-MHz minimum operation	1
• Changed LO frequency range minimum specification from 0.4 GHz to 0.35 GHz	4
• Added <i>Electrical Characteristics</i> table for $f_{LO} = 350$ -MHz performance data	4

PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead/Ball Finish (6)	MSL Peak Temp (3)	Op Temp (°C)	Device Marking (4/5)	Samples
TRF370315IRGER	ACTIVE	VQFN	RGE	24	3000	Green (RoHS & no Sb/Br)	NIPDAU	Level-2-260C-1 YEAR	-40 to 85	TRF37 0315	Samples
TRF370315IRGET	ACTIVE	VQFN	RGE	24	250	Green (RoHS & no Sb/Br)	NIPDAU	Level-2-260C-1 YEAR	-40 to 85	TRF37 0315	Samples
TRF370333IRGER	ACTIVE	VQFN	RGE	24	3000	Green (RoHS & no Sb/Br)	NIPDAU	Level-2-260C-1 YEAR	-40 to 85	TRF37 0333	Samples
TRF370333IRGET	ACTIVE	VQFN	RGE	24	250	Green (RoHS & no Sb/Br)	NIPDAU	Level-2-260C-1 YEAR	-40 to 85	TRF37 0333	Samples
TRF370333IRGETG4	ACTIVE	VQFN	RGE	24	250	Green (RoHS & no Sb/Br)	NIPDAU	Level-2-260C-1 YEAR	-40 to 85	TRF37 0333	Samples

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBsolete: TI has discontinued the production of the device.

(2) **RoHS:** TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (Cl) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

(3) MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

(4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

(5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "-" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

(6) Lead/Ball Finish - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width.

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TAPE AND REEL INFORMATION


*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
TRF370315IRGER	VQFN	RGE	24	3000	330.0	12.4	4.3	4.3	1.5	8.0	12.0	Q1
TRF370315IRGET	VQFN	RGE	24	250	330.0	12.4	4.3	4.3	1.5	8.0	12.0	Q1
TRF370333IRGER	VQFN	RGE	24	3000	330.0	12.4	4.3	4.3	1.5	8.0	12.0	Q1
TRF370333IRGET	VQFN	RGE	24	250	330.0	12.4	4.3	4.3	1.5	8.0	12.0	Q1

TAPE AND REEL BOX DIMENSIONS



*All dimensions are nominal

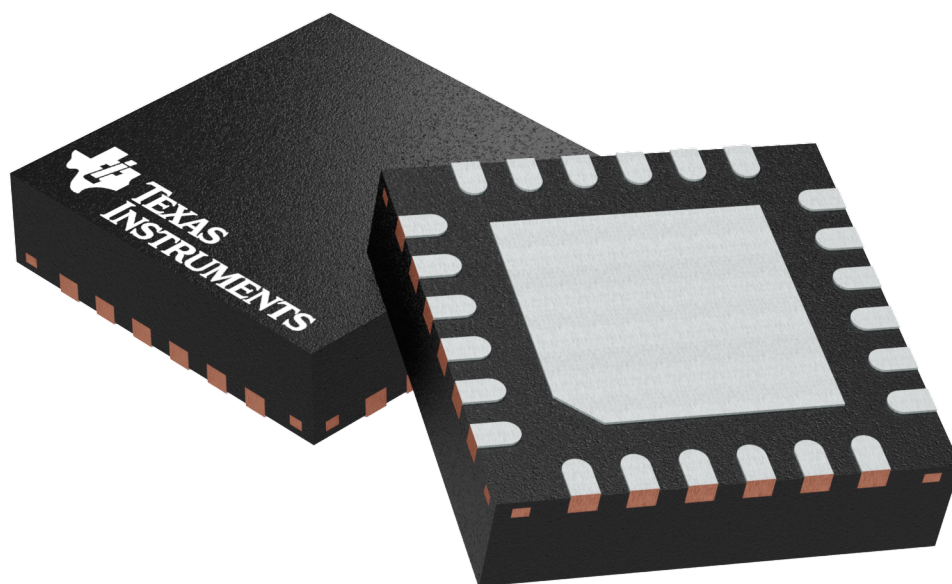
Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
TRF370315IRGER	VQFN	RGE	24	3000	367.0	367.0	38.0
TRF370315IRGET	VQFN	RGE	24	250	367.0	367.0	38.0
TRF370333IRGER	VQFN	RGE	24	3000	367.0	367.0	38.0
TRF370333IRGET	VQFN	RGE	24	250	367.0	367.0	38.0

RGE 24

GENERIC PACKAGE VIEW

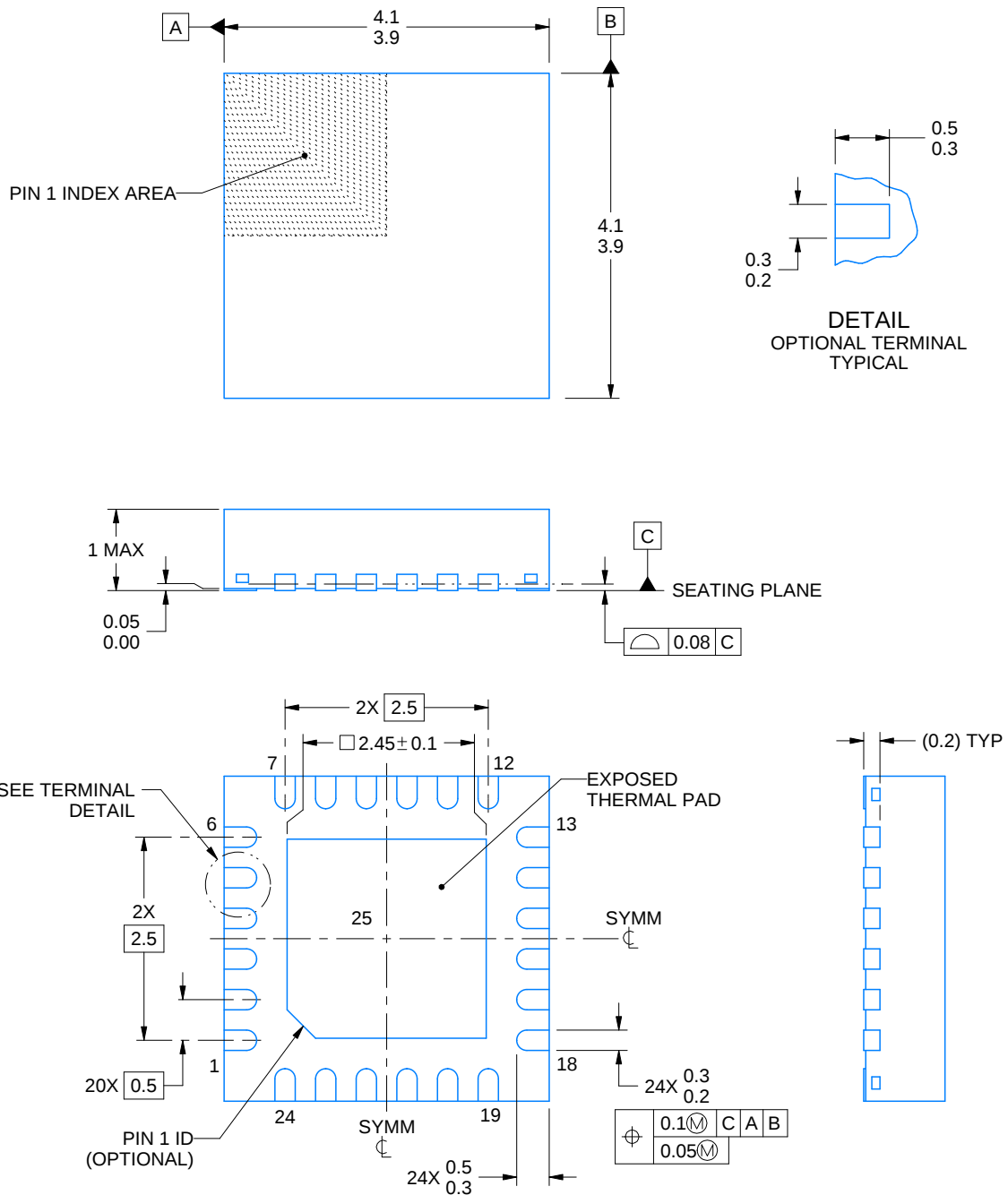
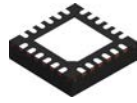
VQFN - 1 mm max height

PLASTIC QUAD FLATPACK - NO LEAD



Images above are just a representation of the package family, actual package may vary.
Refer to the product data sheet for package details.

4204104/H



4219013/A 05/2017

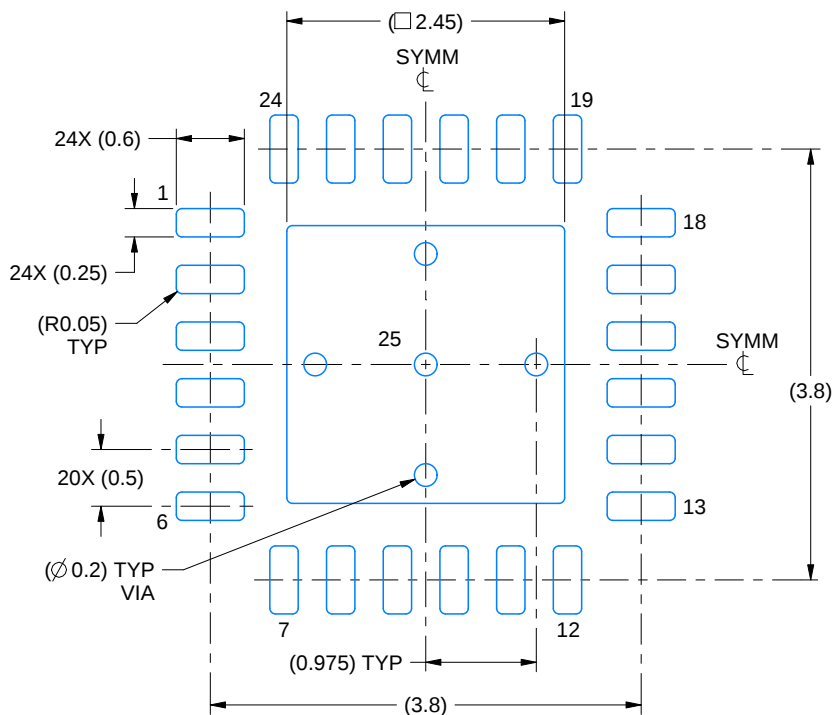
NOTES:

1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. The package thermal pad must be soldered to the printed circuit board for thermal and mechanical performance.

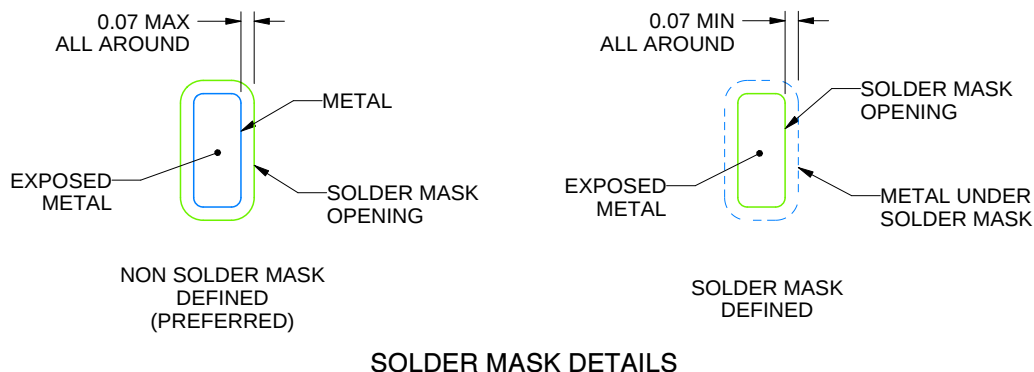
RGE0024B

VQFN - 1 mm max height

PLASTIC QUAD FLATPACK - NO LEAD



LAND PATTERN EXAMPLE
EXPOSED METAL SHOWN
SCALE:15X



4219013/A 05/2017

NOTES: (continued)

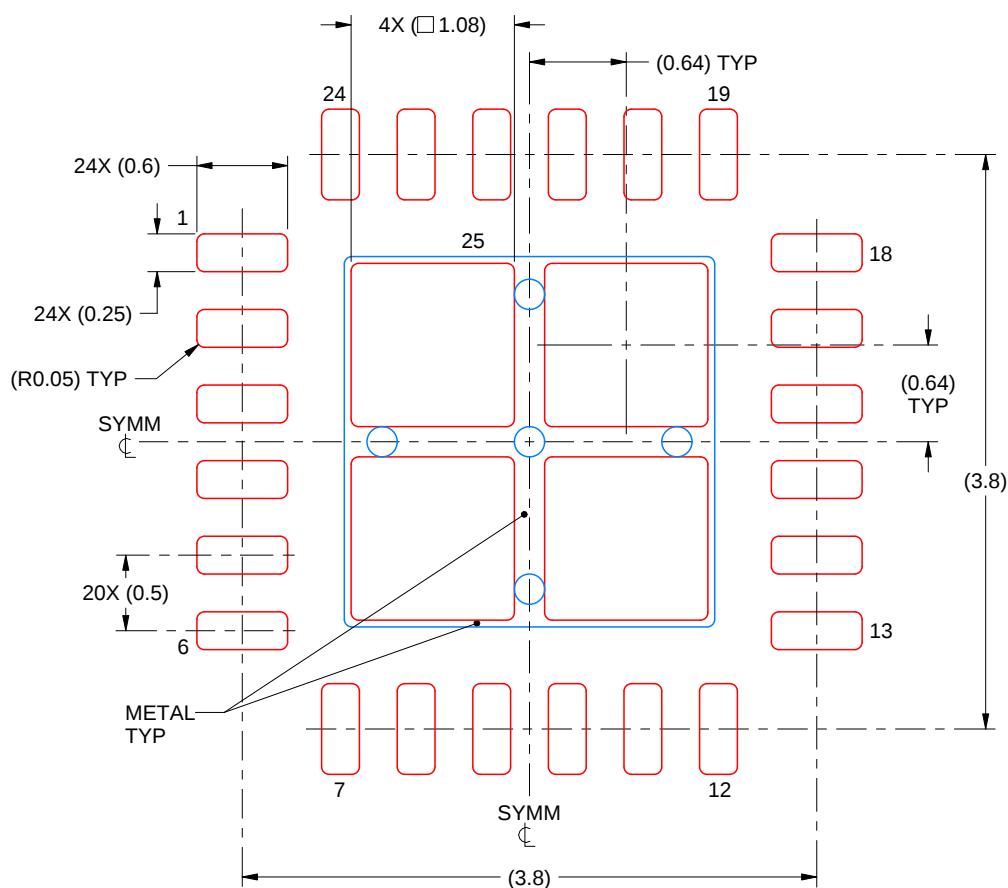
4. This package is designed to be soldered to a thermal pad on the board. For more information, see Texas Instruments literature number SLUA271 (www.ti.com/lit/slua271).
5. Vias are optional depending on application, refer to device data sheet. If any vias are implemented, refer to their locations shown on this view. It is recommended that vias under paste be filled, plugged or tented.

EXAMPLE STENCIL DESIGN

RGE0024B

VQFN - 1 mm max height

PLASTIC QUAD FLATPACK - NO LEAD



SOLDER PASTE EXAMPLE
BASED ON 0.125 mm THICK STENCIL

EXPOSED PAD 25
78% PRINTED SOLDER COVERAGE BY AREA UNDER PACKAGE
SCALE:20X

4219013/A 05/2017

NOTES: (continued)

6. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.

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